

**Search Notes**

Application/Control No.

10/720,155

Examiner

German Viana Di Prisco

Applicant(s)/Patent under  
Reexamination

KOSHINO ET AL.

Art Unit

2616

**SEARCHED**

Class	Subclass	Date	Examiner
370	351	10/1/2007	GV

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST Image and keyword search in USPAT, US-PGPUB, DERWENT, EPO, JPO and IBM_TDB (see attached search strategy)	10/1/2007	GV
Inventor name and Assignee search in PALM ExPO and EAST	10/1/2007	GV
EPO Database( <a href="http://ep.espacenet.com">http://ep.espacenet.com</a> )	10/1/2007	GV
370/395.21.ccls. and (set\$3 or determin\$3) same priority	10/1/2007	GV
Consulted with Ken Vanderpuye and Steven Nguyen	10/1/2007	GV